

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,800	DEVINE ET AL.	
	Examiner Christopher A. Revak	Art Unit 2131	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	204,206	3/14/2005	CR
709	223-229	3/14/2005	CR
713/150-153,165,166, 168,175,191,193,200- 202		3/14/2005	CR